Application/Control No. Applicant(s)/Patent Under Reexamination 10/767,078 NAKAMURA ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 Tan T. Nguyen 2818 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY 324/73.1 US-5,212,442 05-1993 O'Toole et al. Α В US-С US-US-D Ε US-F US-G US-Н US-1 US-J US-US-Κ US-L М US-

FOREIGN PATENT DOCUMENTS

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